

Notice of References Cited	Application/Control No. 10/029,373	Applicant(s)/Patent Under Reexamination LEE, CHUNG J.	
	Examiner Marc A Patterson	Art Unit 1772	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,567,835	10-1996	DeVries et al.	556/453
	B	US-6,329,227 B2	12-2001	Anda et al.	438/151
	C	US-6,057,904	05-2000	Kim et al.	349/143
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP-0227163 A2	07-1987	EPO	Wong	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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